

Search Notes

Application/Control No.

10/564,758

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under
Reexamination

LUTZ ET AL.

Art Unit

2612

SEARCHED

Class	Subclass	Date	Examiner
340	572.7	9/12/2007	JAT
	572.5	9/12/2007	JAT
235	492	9/12/2007	JAT
343	748	9/12/2007	JAT
	750	9/12/2007	JAT
	806	9/12/2007	JAT
	866	9/12/2007	JAT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR